

Silicon diffused power transistors**BUX84; BUX85**

High-voltage, high-speed, glass-passivated npn power transistors in TO-220 envelopes, intended for use in converters, inverters, switching regulators, motor control systems and switching applications.

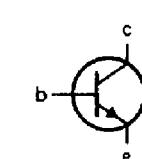
QUICK REFERENCE DATA

		BUX84	BUX85
Collector-emitter voltage (peak value; $V_{BE} = 0$)	V_{CESM}	max. 800	1000 V
Collector-emitter voltage (open base)	V_{CEO}	max. 400	450 V
Collector-emitter saturation voltage	V_{CEsat}	max. 1	V
Collector current (DC)	I_C	max. 2	A
Collector current (peak value)	I_{CM}	max. 3	A
Total power dissipation up to $T_{mb} = 50^\circ\text{C}$	P_{tot}	max. 40	W
Fall time	t_f	max. 0,4	μs

MECHANICAL DATA

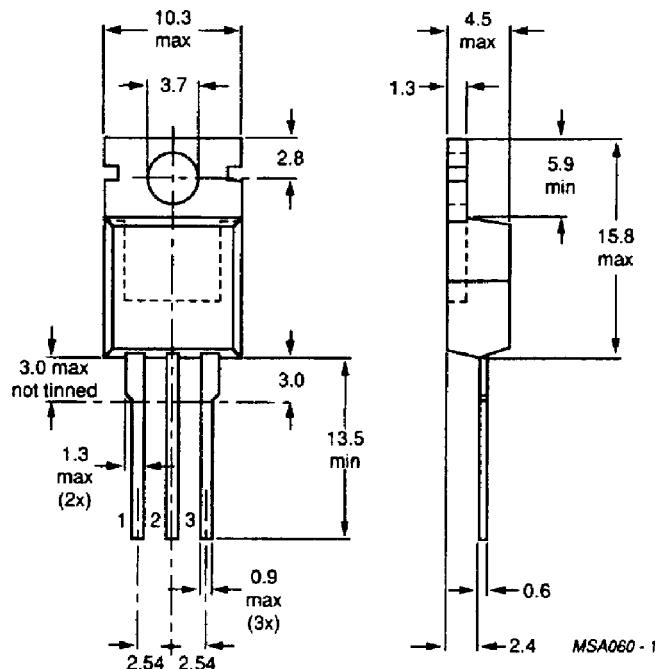
Dimensions in mm

Fig. 1 TO-220AB.



Pinning:

- 1 = base
- 2 = collector
- 3 = emitter



Collector connected to tab

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RATINGS Limiting values in accordance with the Absolute Maximum System (IEC134)

		BUX84	BUX85	
Collector-emitter voltage (peak value; $V_{BE} = 0$)	V_{CESM}	max 800	1000	V
Collector-emitter voltage (open base)	V_{CEO}	max 400	450	V
Collector current (DC)	I_C	max	2	A
Collector current (peak value) $t_p = 2 \text{ ms}$	I_{CM}	max	3	A
Base current (DC)	I_B	max	0,75	A
Base current (peak value)	I_{BM}	max	1	A
Reverse base current (peak value) *	$-I_{BM}$	max	1	A
Total power dissipation up to $T_{mb} = 50 \text{ }^\circ\text{C}$	P_{tot}	max	40	W
Storage temperature range	T_{stg}	–65 to +150		$^\circ\text{C}$
Junction temperature	T_j	max	150	$^\circ\text{C}$
 THERMAL RESISTANCE				
From junction to mounting base	$R_{th j-mb}$	=	2,5	K/W
From junction to ambient in free air	$R_{th j-a}$	=	70	K/W
 CHARACTERISTICS				
Collector cut-off current **		$T_j = 25 \text{ }^\circ\text{C}$ unless otherwise specified		
$V_{CEM} = V_{CESMmax}; V_{BE} = 0$	I_{CES}	max.	200	μA
$V_{CEM} = V_{CESMmax}; V_{BE} = 0; T_j = 125 \text{ }^\circ\text{C}$	I_{CES}	max.	1,5	mA
DC current gain				
$I_C = 5 \text{ mA}; V_{CE} = 5 \text{ V}$	h_{FE}	min.	15	
$I_C = 100 \text{ mA}; V_{CE} = 5 \text{ V}$	h_{FE}	min.	20	
	h_{FE}	typ.	50	
	h_{FE}	max.	100	

* Turn-off current.

** Measured with a half-sinewave voltage (curve tracer).

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Emitter cut-off current

 $I_C = 0$; $V_{EB} = 5$ V I_{EBO} max. 1 mA

Saturation voltages

 $I_C = 0,3$ A; $I_B = 30$ mA V_{CEsat} max. 0,8 V $I_C = 1$ A; $I_B = 0,2$ A V_{CEsat} max. 1,0 V $I_C = 1$ A; $I_B = 0,2$ A V_{BEsat} max. 1,1 V

Collector-emitter sustaining voltage

 $I_C = 100$ mA; $I_{Boff} = 0$; $L = 25$ mH

	BUX84	BUX85
$V_{CEO}sust$	min. 400	450
		V

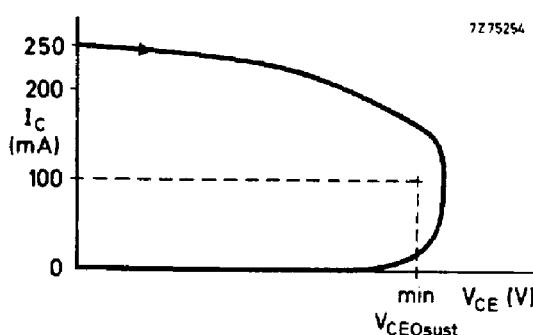
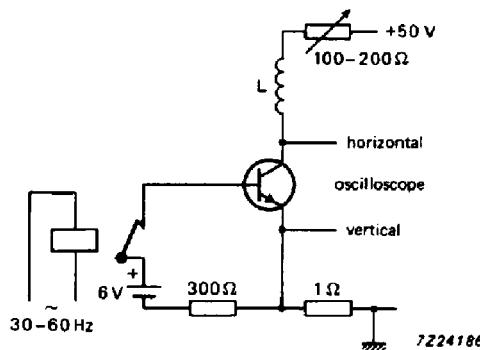


Fig. 2 Oscilloscope display for sustaining voltage.

Fig. 3 Test circuit for $V_{CEO}sust$.

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CHARACTERISTICS (continued)

 $T_j = 25^\circ\text{C}$ unless otherwise specifiedTransition frequency at $f = 1 \text{ MHz}$ $I_C = 0.2 \text{ A}; V_{CE} = 10 \text{ V}$ $f_T \text{ typ } 20 \text{ MHz}$

Switching times

 $I_{Con} = 1 \text{ A}; V_{CC} = 250 \text{ V}$ $I_{Bon} = 0.2 \text{ A}; -I_{Boff} = 0.4 \text{ A}$

Turn-on time

 $t_{on} \text{ typ } 0.2 \mu\text{s}$
 $\text{max. } 0.5 \mu\text{s}$

Turn-off: Storage time

 $t_s \text{ typ } 2 \mu\text{s}$
 $\text{max. } 3.5 \mu\text{s}$

Fall time

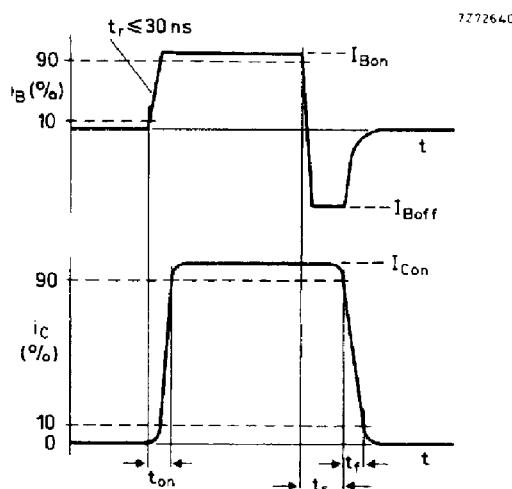
 $t_f \text{ typ } 0.4 \mu\text{s}$ Fall time, $T_{mb} = 95^\circ\text{C}$ $t_f \text{ max. } 1.4 \mu\text{s}$ 

Fig. 4 Switching times waveforms with resistive load.

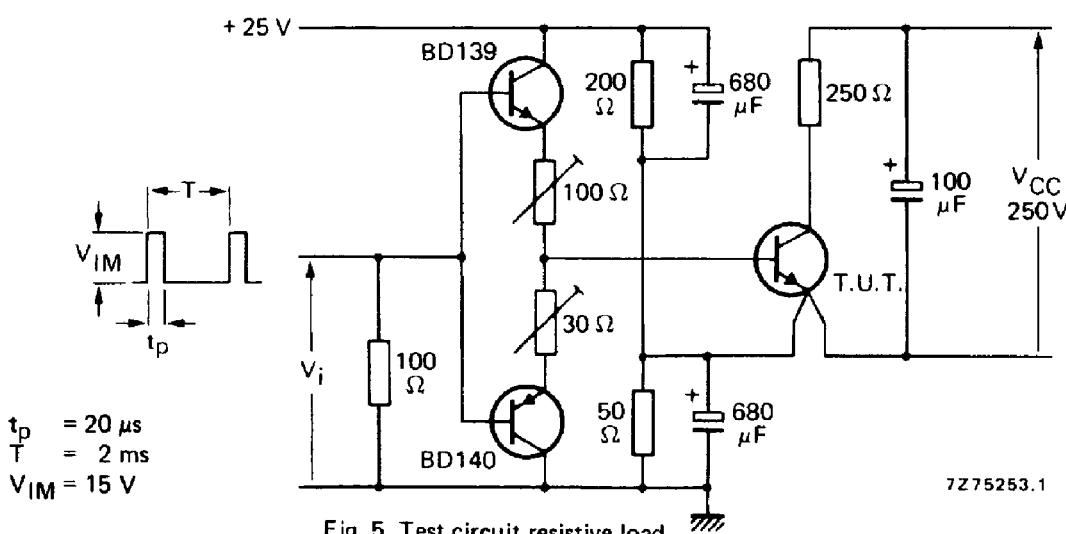
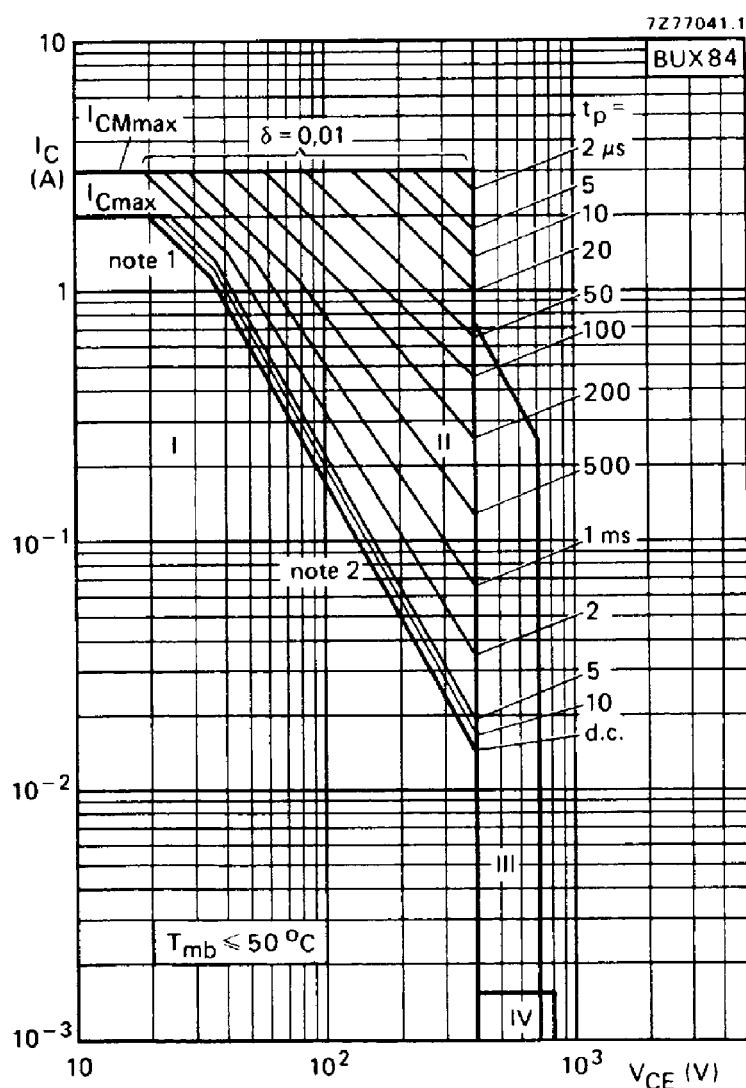


Fig. 5 Test circuit resistive load.

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1. $P_{tot\ max}$ and $P_{peak\ max}$ lines.
 2. Second-breakdown limits.

I Region of permissible DC operation

II Permissible extension for repetitive pulse operation

III Area of permissible operation during turn-on in single transistor converters, provided $R_{BF} \leq 100 \Omega$ and $t_D \leq 0,6 \mu s$

IV Repetitive pulse operation in this region is permissible, provided $V_{BE} \leq 0$ and $t_p \leq 2$ ms

Fig. 6 Safe operating area.

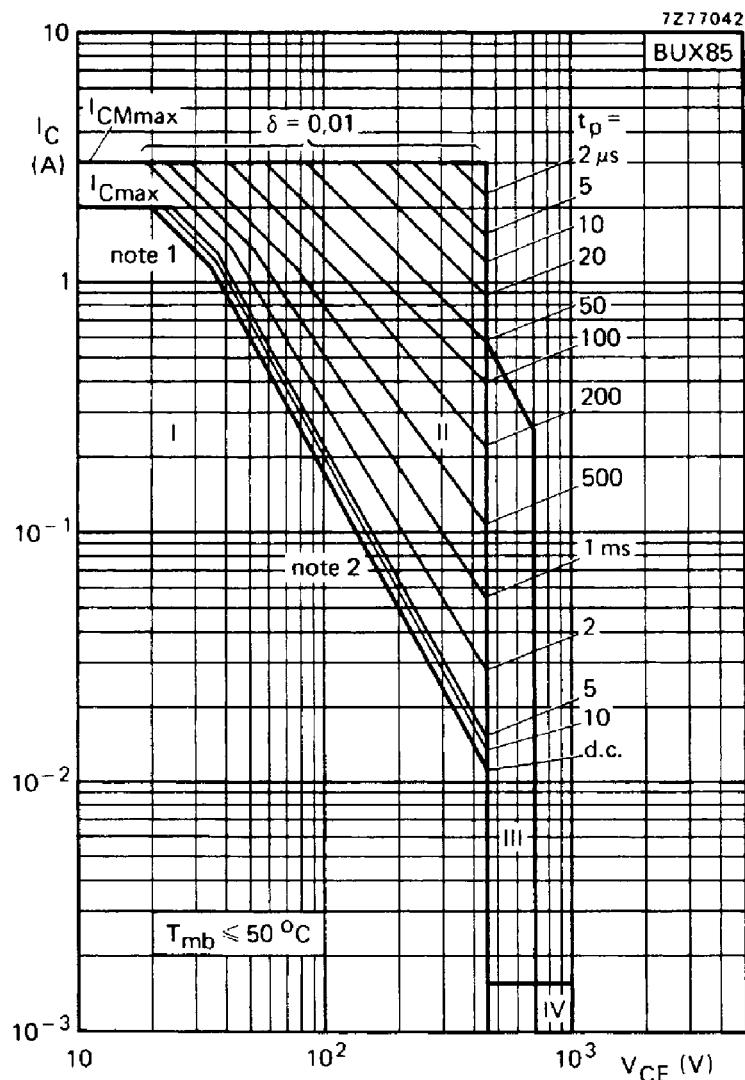
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1. $P_{tot\ max}$ and $P_{peak\ max}$ lines.
 2. Second-breakdown limits.
- I Region of permissible DC operation
 - II Permissible extension for repetitive pulse operation
 - III Area of permissible operation during turn-on in single transistor converters, provided $R_{BE} \leq 100 \Omega$ and $t_p \leq 0,6 \mu s$
 - IV Repetitive pulse operation in this region is permissible, provided $V_{BE} \leq 0$ and $t_p \leq 2 \text{ ms}$

Fig. 7 Safe operating area.

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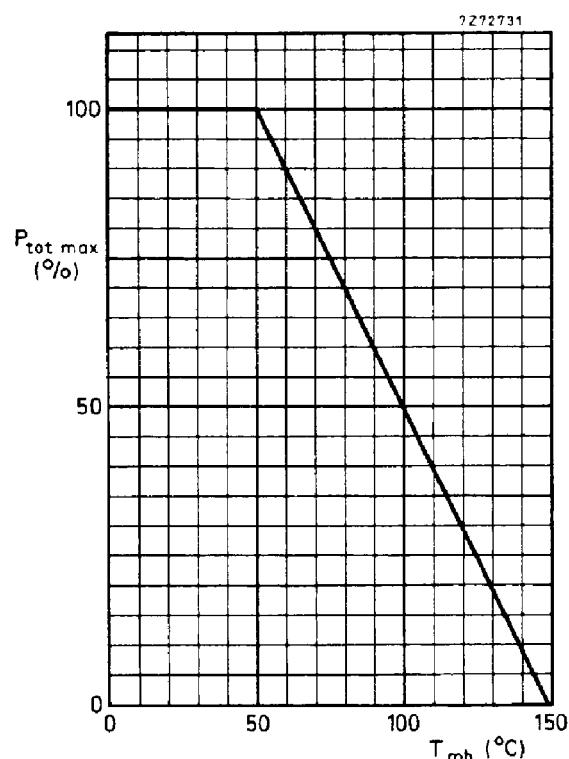


Fig. 8 Power derating curve.

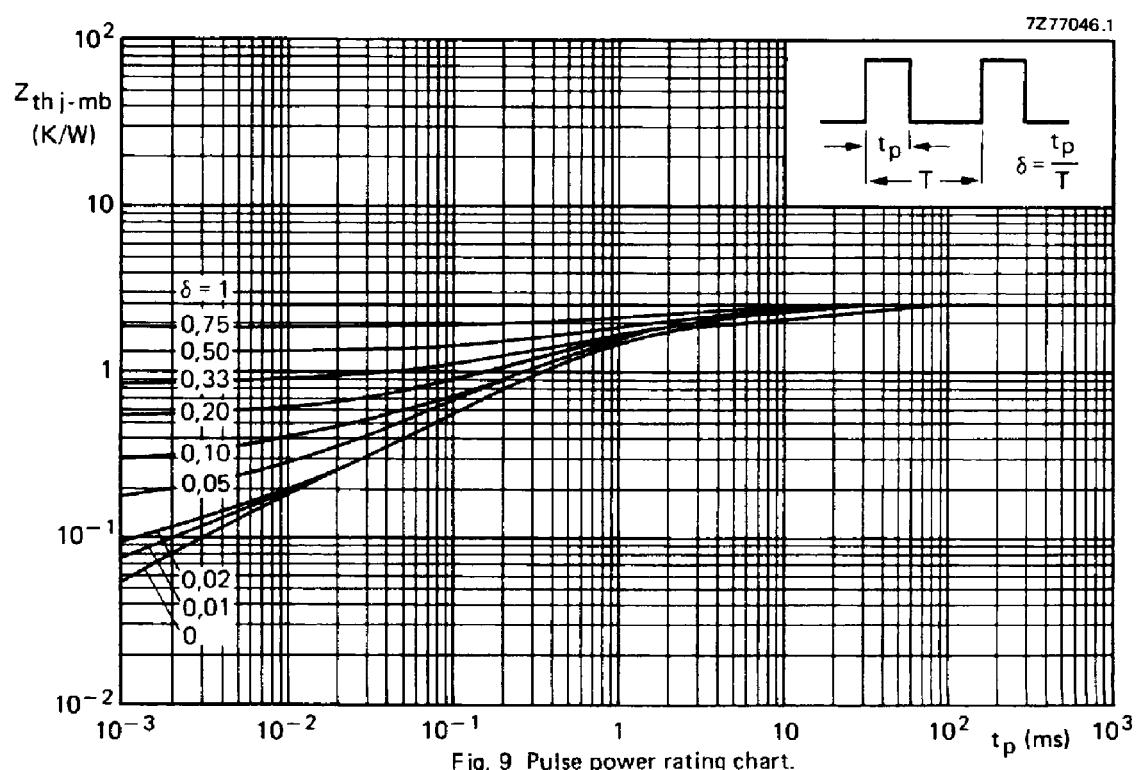


Fig. 9 Pulse power rating chart.

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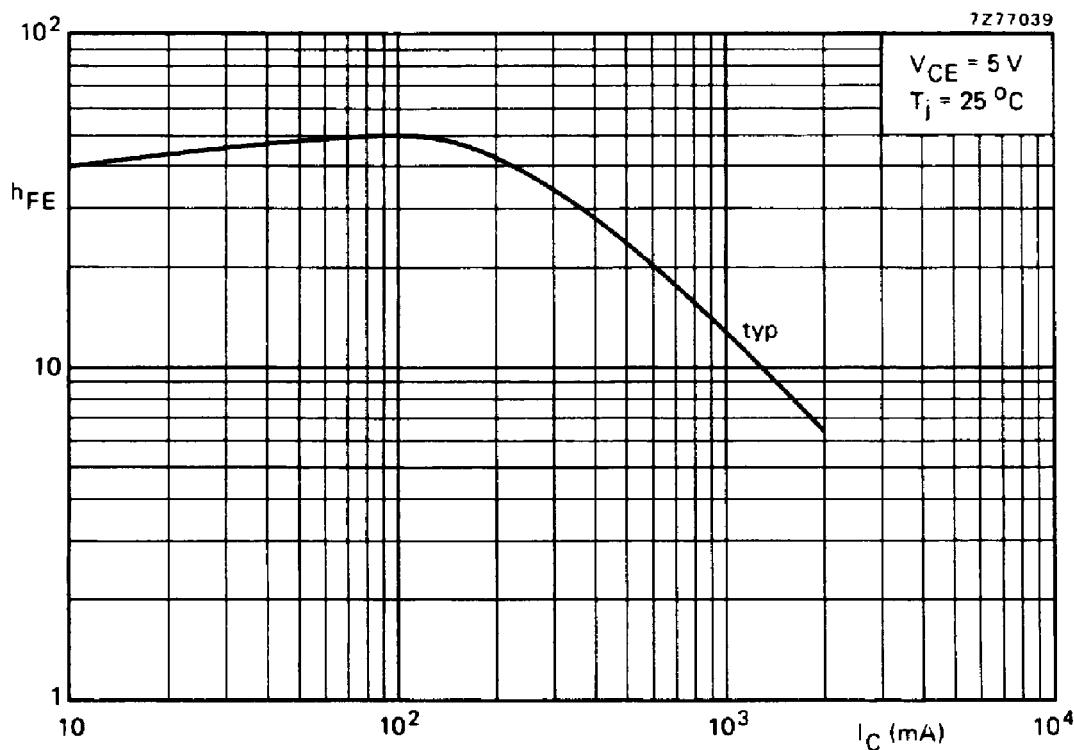


Fig. 10 Typical DC current gain.

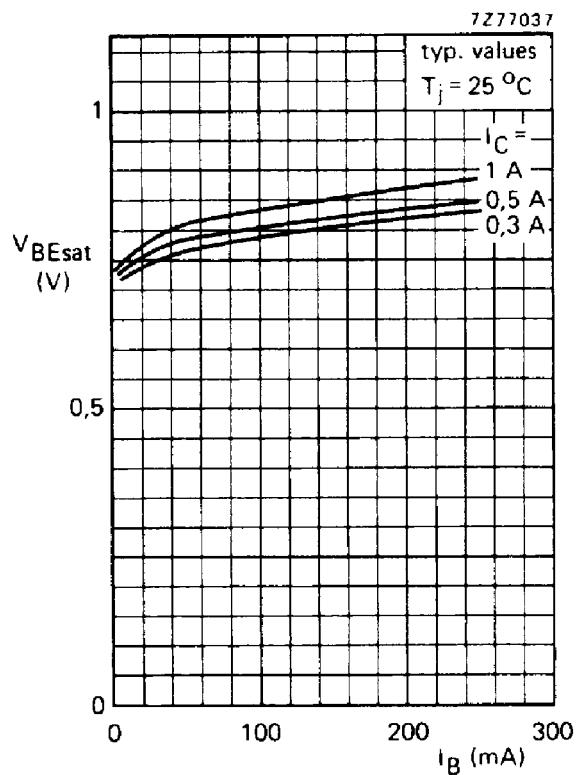
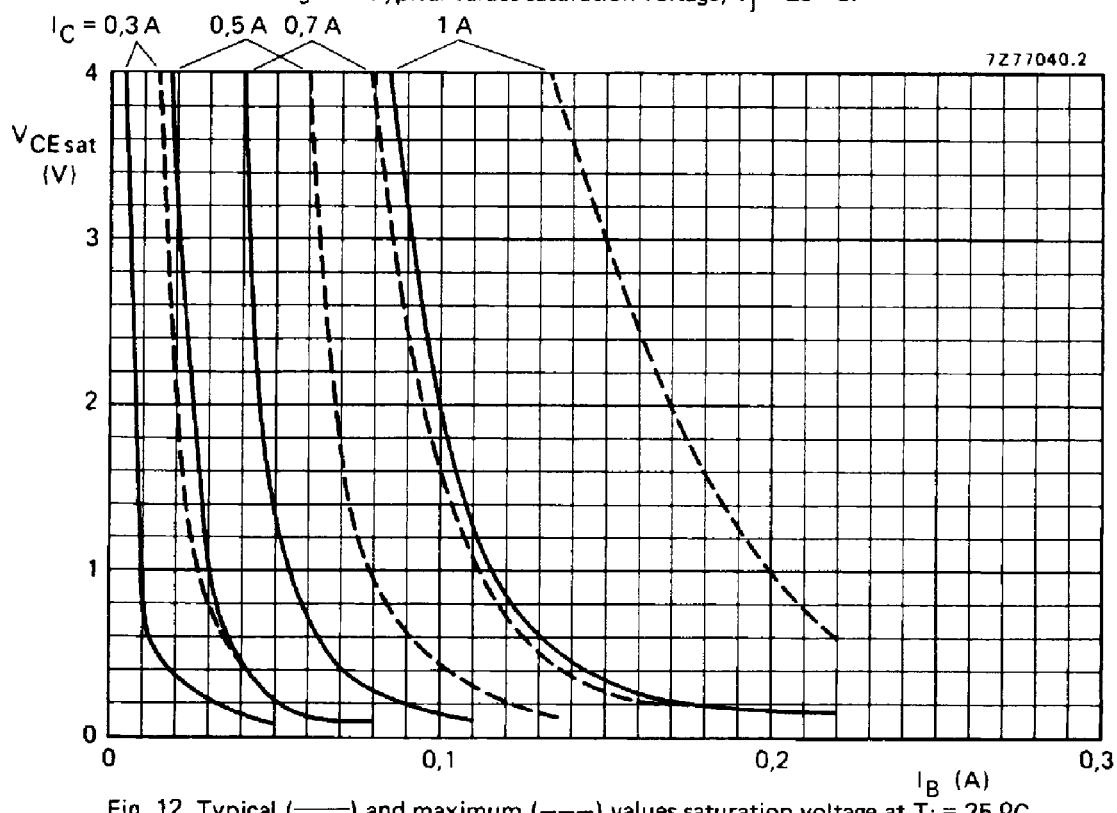
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Fig. 11 Typical values saturation voltage, $T_j = 25 \text{ } ^\circ\text{C}$.Fig. 12 Typical (—) and maximum (---) values saturation voltage at $T_j = 25 \text{ } ^\circ\text{C}$.

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